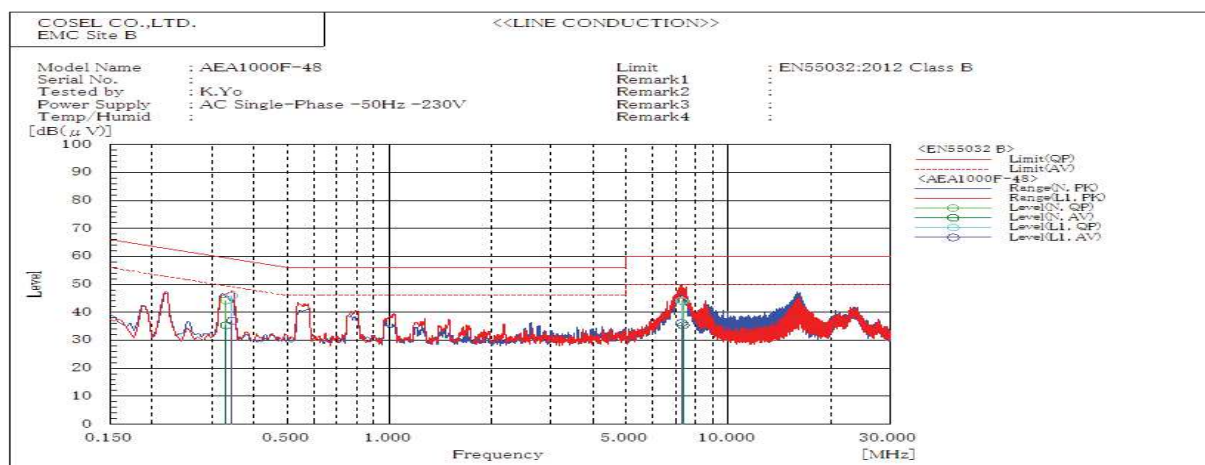
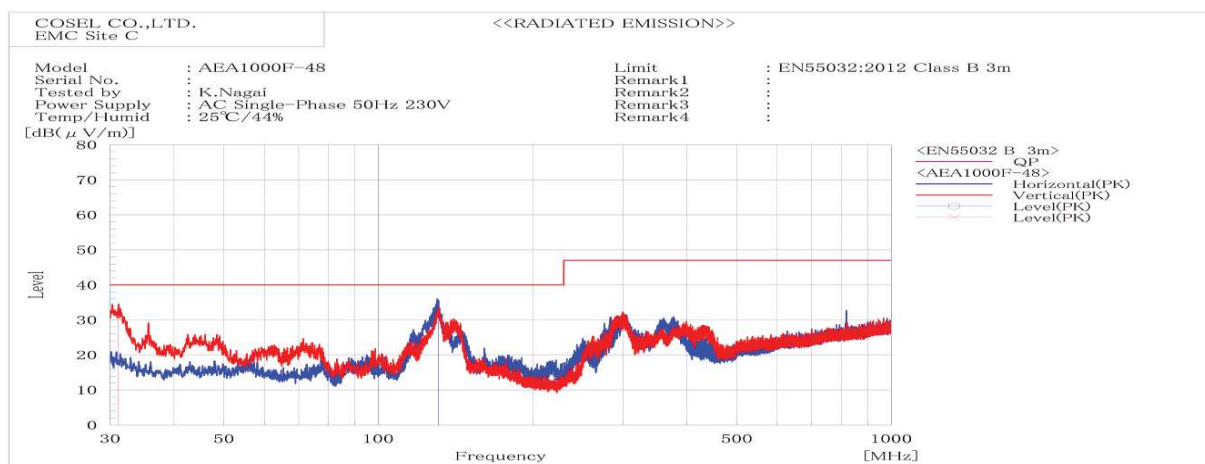


DATA SHEET		Date	12-Oct-21
Model	AEA1000F-48	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	44 %RH
		Tested by	K.Nagai



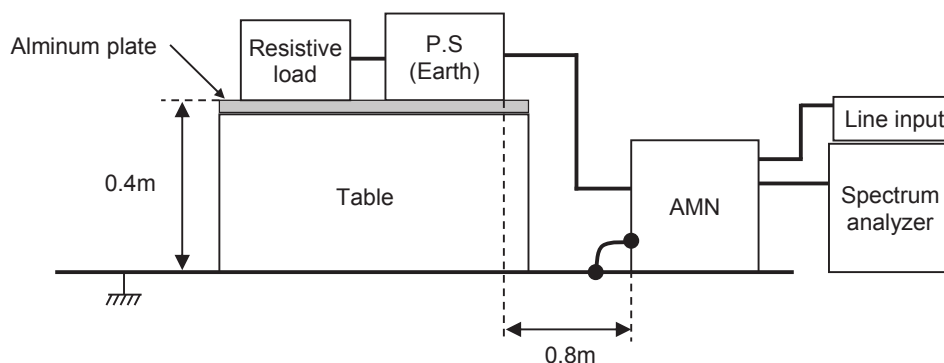
Frequency	Line	Level		Limit		Margin		Pass/Fail	Remark
MHz		dB(μV)		dB(μV)		dB			
		QP	AV	QP	AV	QP	AV		
0.345	L1	45.9	37.1	59.1	49.1	13.2	12	Pass	
7.269	L1	44.1	36.3	60	50	15.9	13.7	Pass	
0.33	N	44.3	35.3	59.4	49.4	15.1	14.1	Pass	
7.342	N	43.9	35.3	60	50	16.1	14.7	Pass	



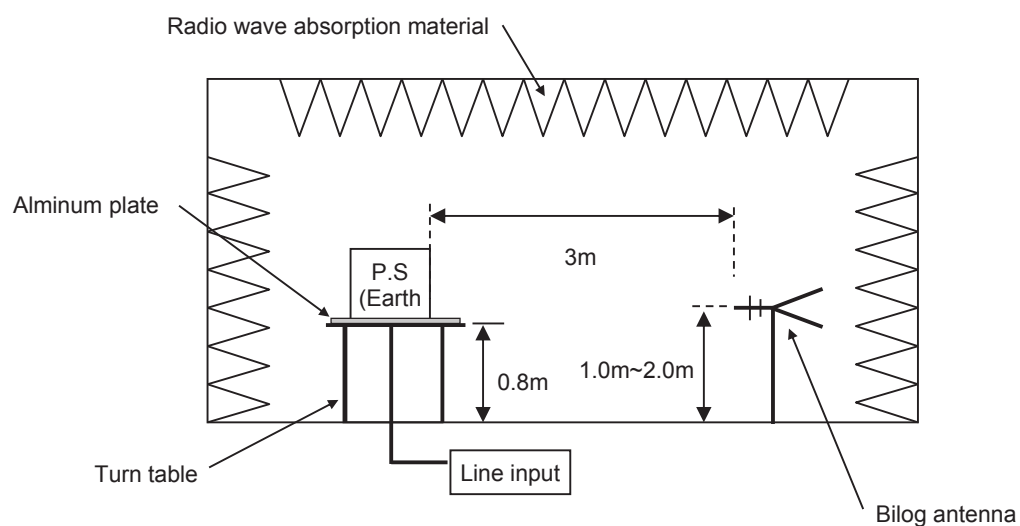
Frequency MHz	Polarization	Stability	Level dB(μV/m)	Limit dB(μV/m)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	QP	QP				
131.002	H	Stable	31.3	40	8.7	Pass	200	0	
31.075	V	Stable	30.7	40	9.3	Pass	100.2	247.6	
130.844	V	Stable	29.5	40	10.5	Pass	109.8	37.2	

DATA SHEET		Date	12-Oct-21
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	44 %RH
		Tested by	K.Nagai

1. Line conduction



2. Radiated emission

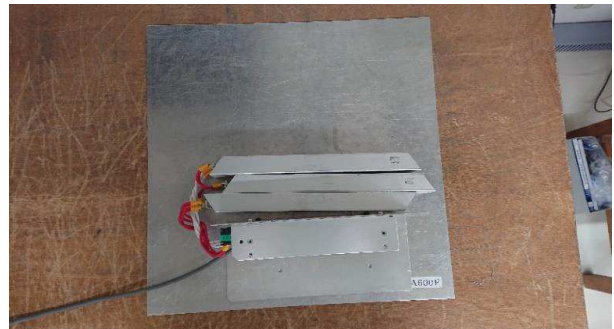


Conditions

Test : EMI
Model Name : AEA1000F

○Photographs of Test Set-Up

1.LINE CONDUCTION



2.RADIATED EMISSION

